

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/600,545	LEE ET AL.	
Examiner	Art Unit	David Mis	2817
			Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-			
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**NON-PATENT DOCUMENTS**

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U	Abstract for KR 2003083887 A, Lee et al, 11/01/2003.		
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